

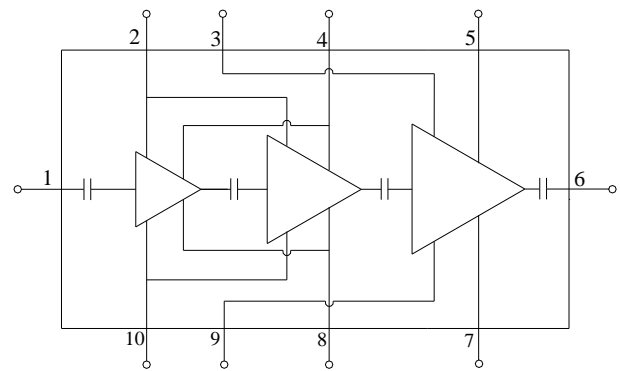
## Applications

- Satellite Communications
- Data Link
- Radar

## Product Features

- Frequency Range: 13.4 – 16.5 GHz
- $P_{SAT}$ : 44 dBm @ PIN = 17 dBm
- PAE: >28% @ PIN = 17 dBm
- Large Signal Gain: 27 dB @ PIN = 17 dBm
- Small Signal Gain: >33 dB
- Bias:  $V_D = 28$  V,  $I_{DQ} = 450$  mA,  $V_G = -2.5$  V Typical
- Process Technology: TQGaN15
- Chip Dimensions: 4.35 x 3.33 x 0.10 mm
- Performance Under CW Operation

## Functional Block Diagram



## General Description

TriQuint's TGA2219 is a Ku-band, high power MMIC amplifier fabricated on TriQuint's production 0.15um GaN on SiC process. The TGA2219 operates from 13.4 – 16.5 GHz and provides 25 W of saturated output power with 27 dB of large signal gain and greater than 28% power-added efficiency.

This high performance combination provides system designers the flexibility to improve system performance while reducing size and cost.

The TGA2219 is fully matched to 50 Ohms with integrated DC blocking capacitors on RF ports simplifying system integration. It is ideally suited for military and commercial Ku-band radar and satellite communication systems.

Lead-free and RoHS compliant.

Evaluation boards are available upon request.

## Pad Configuration

Pad No.	Symbol
1	RF In
2, 10	$V_{G12}$
3, 9	$V_{G3}$
4, 8	$V_{D12}$
5, 7	$V_{D3}$
6	RF Out

## Ordering Information

Part	ECCN	Description
TGA2219	3A001.b.2.c	13.4 – 16.5 GHz 25 W GaN Power Amplifier

### Absolute Maximum Ratings

Parameter	Value
Drain Voltage ( $V_D$ )	29.5 V
Gate Voltage Range ( $V_G$ )	-8 to -0 V
Drain Current ( $I_{D1-2}$ )	2.9 A
Drain Current ( $I_{D3}$ )	4.3 A
Gate Current	See plot on page 3
Power Dissipation ( $P_{DISS}$ ), 85°C, CW	73 W
Input Power ( $P_{IN}$ ), CW, 50Ω, $V_D = 28$ V, $I_{DQ} = 450$ mA, 85°C	30 dBm
Input Power ( $P_{IN}$ ), CW, VSWR 3:1, $V_D = 28$ V, $I_{DQ} = 450$ mA, 85°C	27 dBm
Channel Temperature ( $T_{CH}$ )	275°C
Mounting Temperature (30 seconds)	320°C
Storage Temperature	-40 to 150°C

Operation of this device outside the parameter ranges given above may cause permanent damage. These are stress ratings only, and functional operation of the device at these conditions is not implied.

### Recommended Operating Conditions

Parameter	Value
Drain Voltage ( $V_D$ )	28 V
Drain Current ( $I_{DQ}$ )	450 mA (Total)
Gate Voltage ( $V_G$ )	-2.5 V (Typ.)

Electrical specifications are measured at specified test conditions. Specifications are not guaranteed over all recommended operating conditions.

### Electrical Specifications

Test conditions unless otherwise noted: 25°C,  $V_D = 28$  V,  $I_{DQ} = 450$  mA,  $V_G = -2.5$  V Typical, CW

Parameter	Min	Typical	Max	Units
Operational Frequency Range	13.4		16.5	GHz
Small Signal Gain		> 33		dB
Input Return Loss		> 11		dB
Output Return Loss		> 5		dB
Power Gain ( $P_{in} = 17$ dBm)		27		dB
Output Power ( $P_{in} = 17$ dBm)		44		dBm
Power Added Efficiency ( $P_{in} = 17$ dBm)		> 28		%
Small Signal Gain Temperature Coefficient		-0.8		dB/°C
Output Power Temperature Coefficient (Temp: 25°C – 85°C @ $P_{in} = 17$ dBm)		-0.01		dB/°C
Recommended Operating Voltage		20 to 28	28	V

**Thermal and Reliability Information**

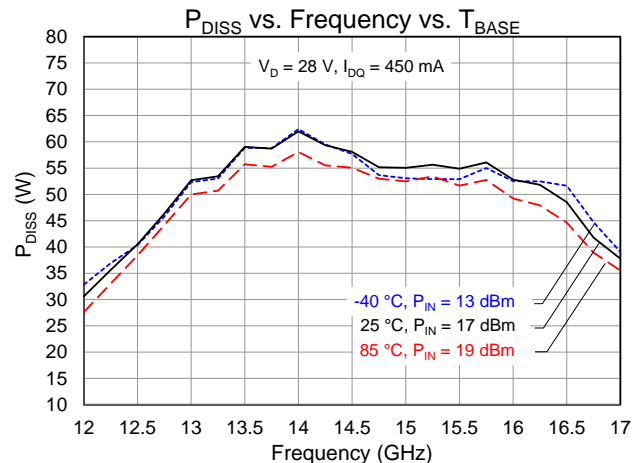
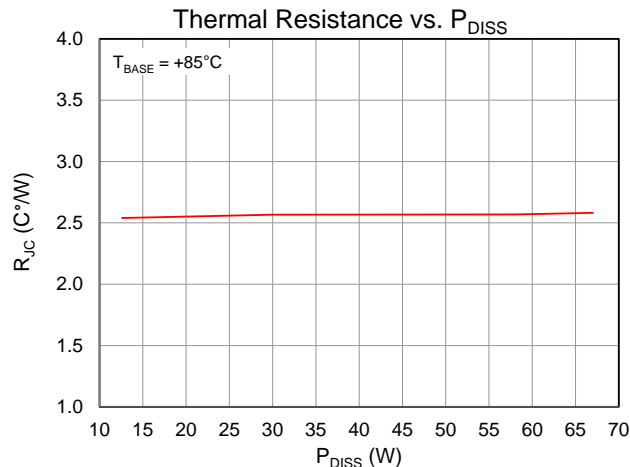
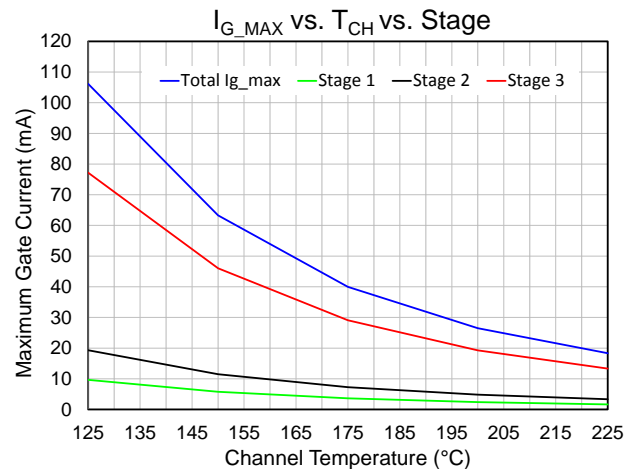
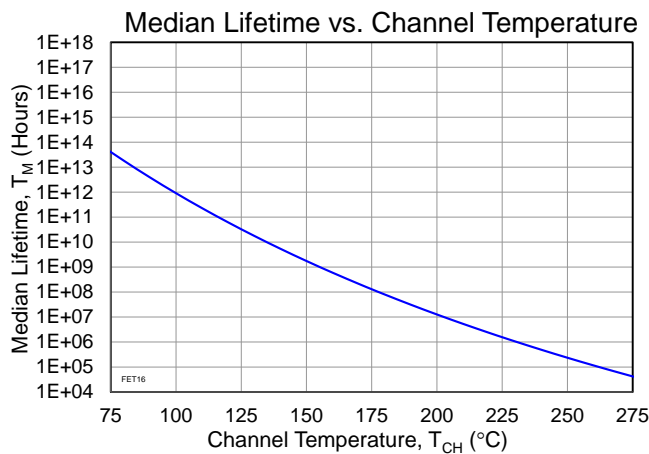
Parameter	Test Conditions	Value	Units
Thermal Resistance ( $\theta_{JC}$ ) <sup>(1)</sup>	$T_{base} = 85^{\circ}C$	2.54	$^{\circ}C/W$
Channel Temperature ( $T_{CH}$ ) (No RF drive)	$V_D = 28 V, I_{DQ} = 450 mA$	117	$^{\circ}C$
Median Lifetime ( $T_M$ )	$P_{DISS} = 12.6 W$	$4.3 \times 10^{11}$	Hrs
Thermal Resistance ( $\theta_{JC}$ ) <sup>(1)</sup>	$T_{base} = 85^{\circ}C, CW, V_D = 28 V, I_{DQ} = 450 mA$	2.57	$^{\circ}C/W$
Channel Temperature ( $T_{CH}$ ) (Under RF drive)	Freq = 14.0 GHz, $I_{D\_Drive} = 2.9 A,$	234	$^{\circ}C$
Median Lifetime ( $T_M$ )	$P_{IN} = 19 dBm, P_{OUT} = 44.5 dBm, P_{DISS} = 58 W$	$3.66 \times 10^6$	Hrs

Notes:

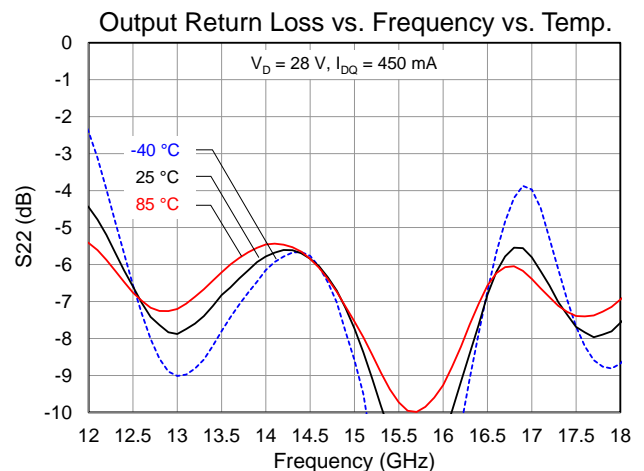
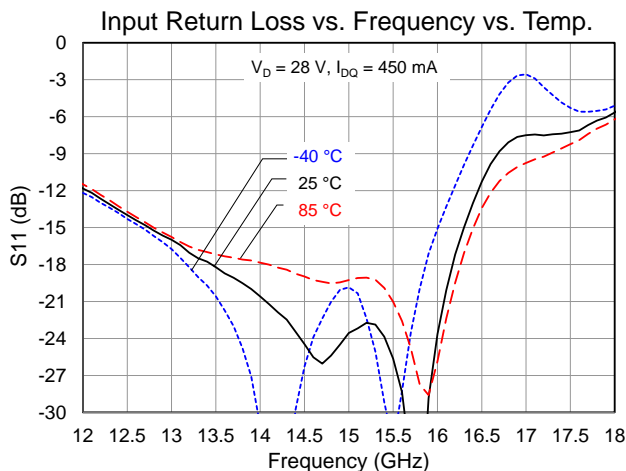
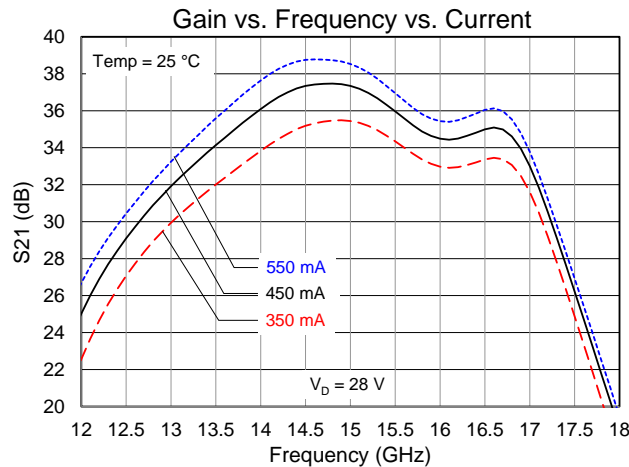
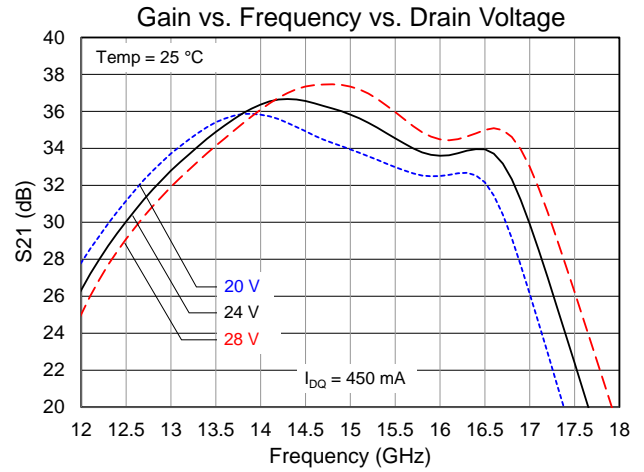
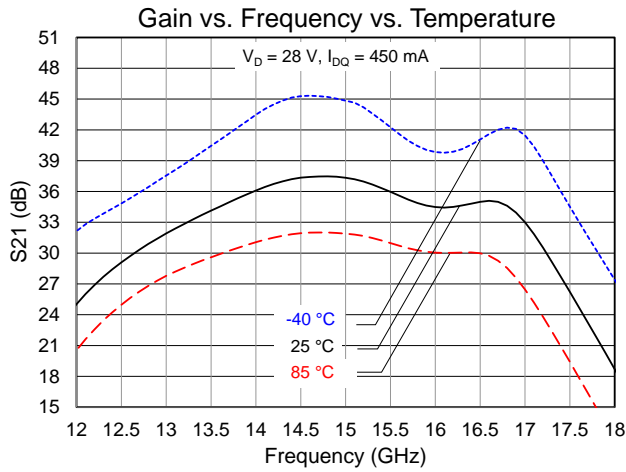
1. Thermal resistance measured to back of carrier plate. MMIC mounted on 40 mils CuMo (75/25) carrier using 1.5 mil AuSn.

**Median Lifetime**

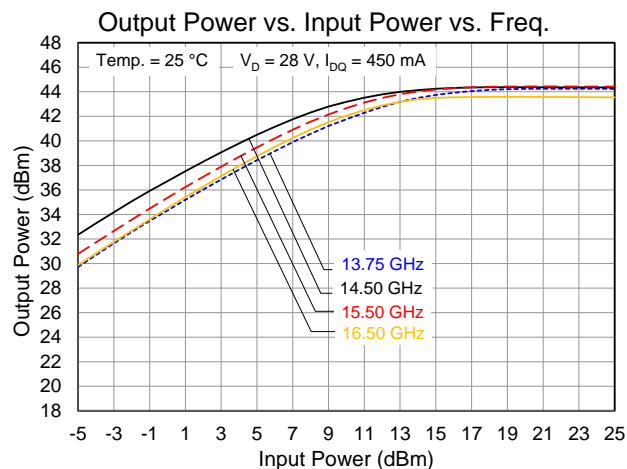
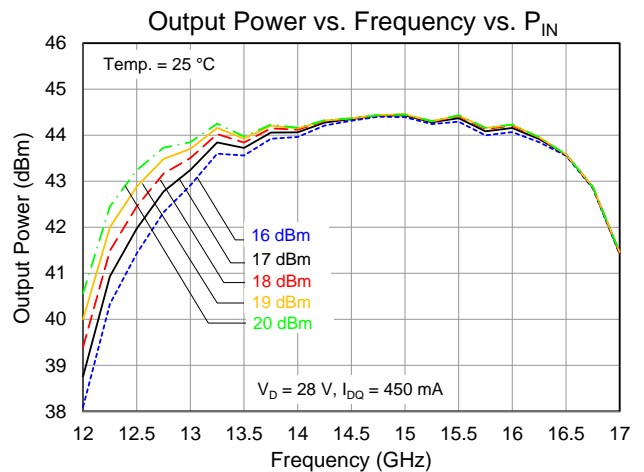
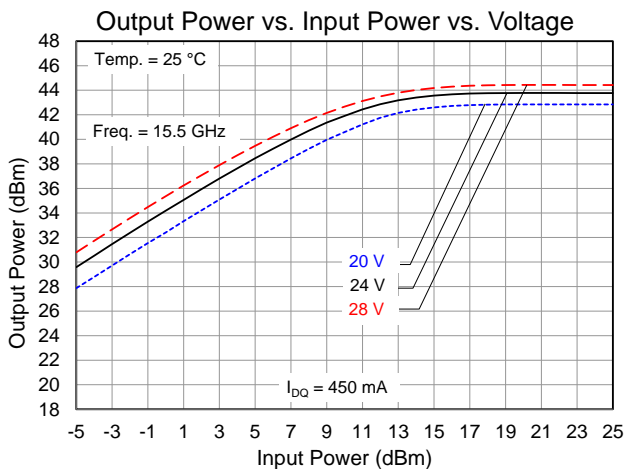
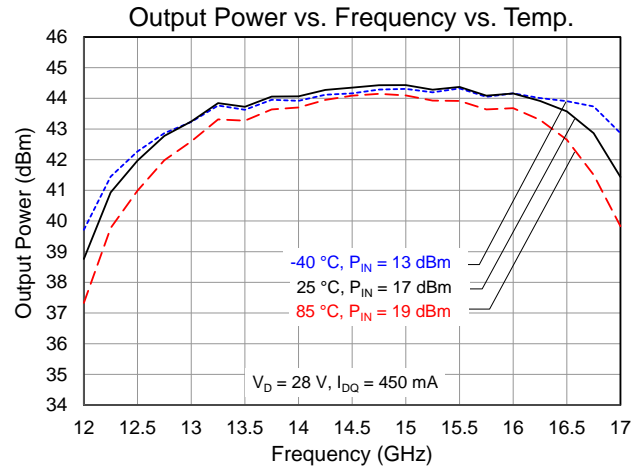
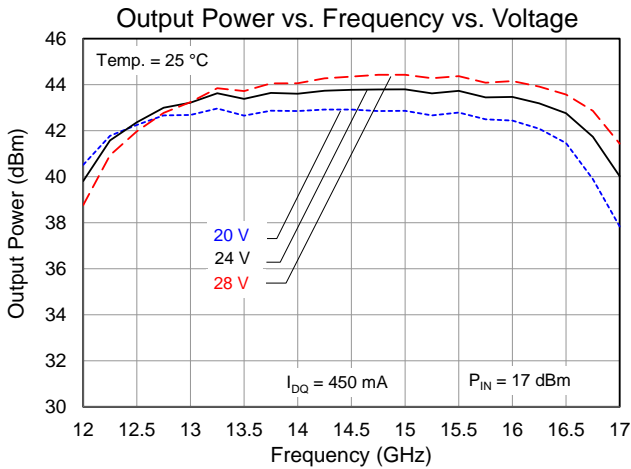
Test Conditions:  $V_D = 28 V$ ; Failure Criteria = 10% reduction in  $I_{D\_MAX}$



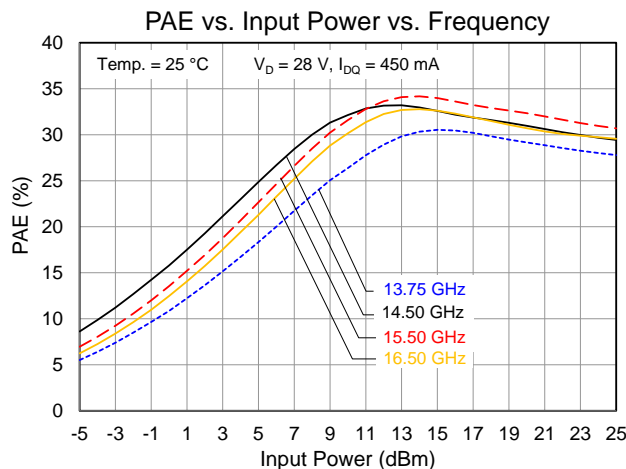
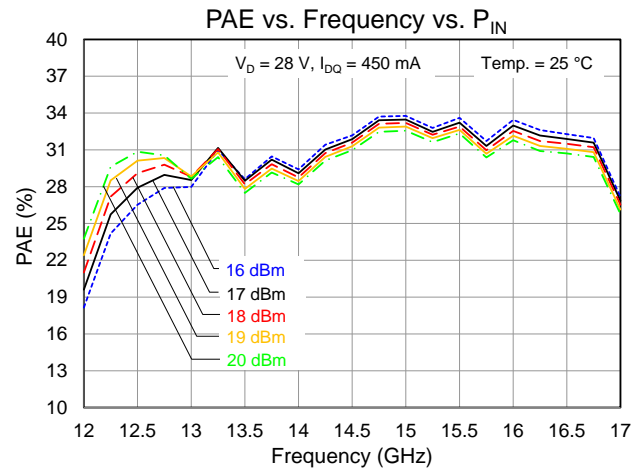
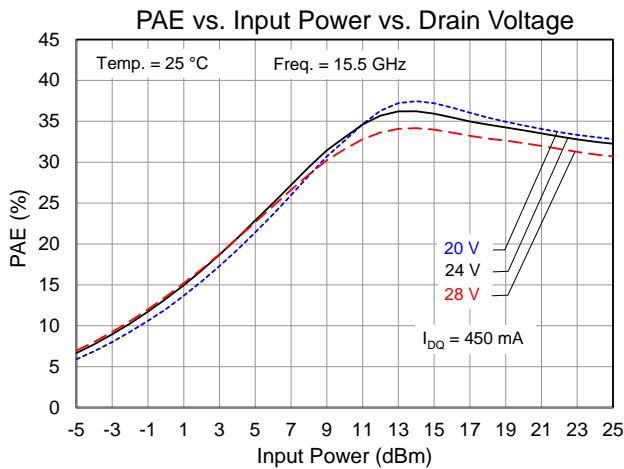
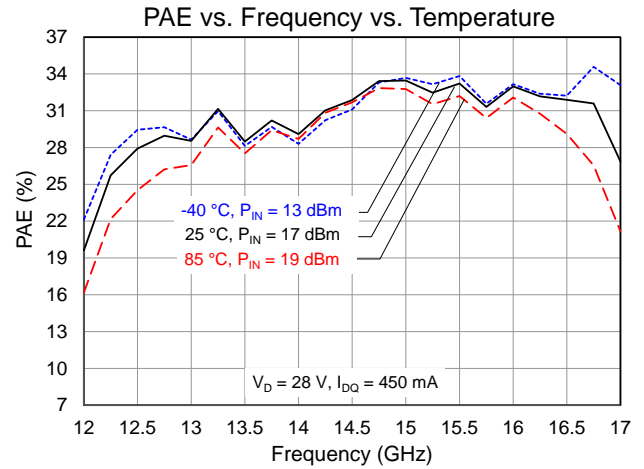
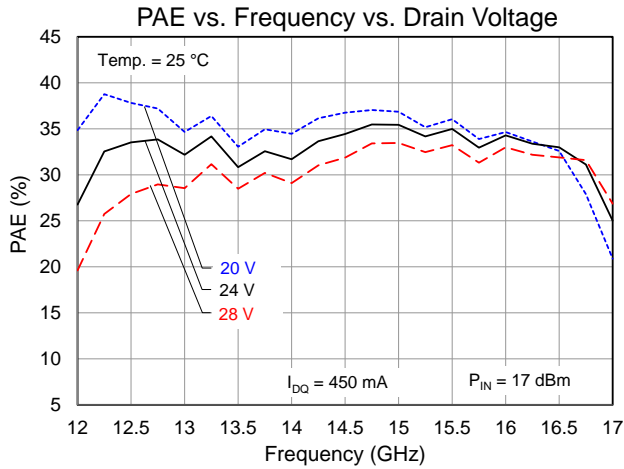
Typical Performance (Small Signal)



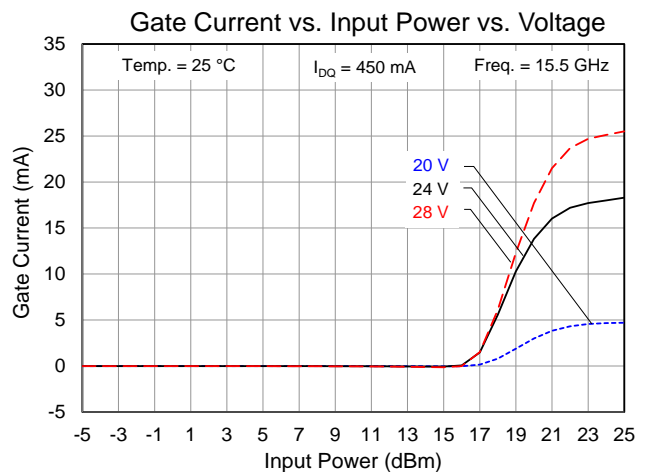
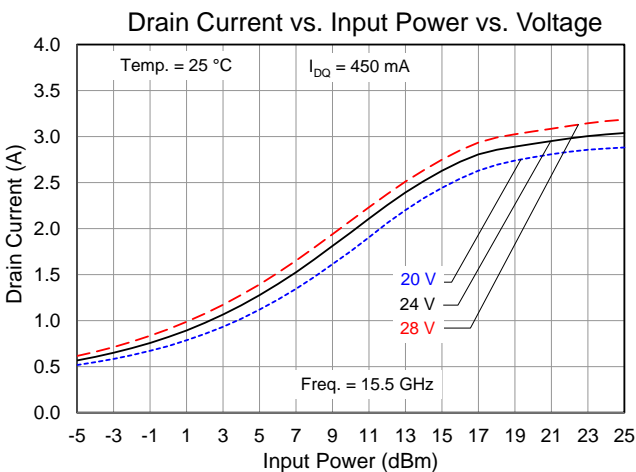
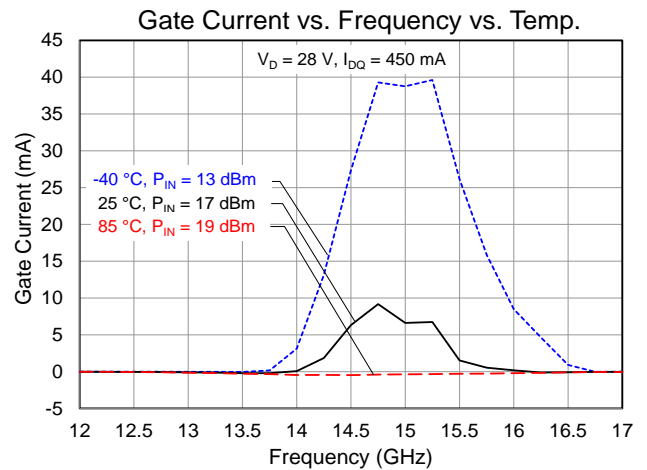
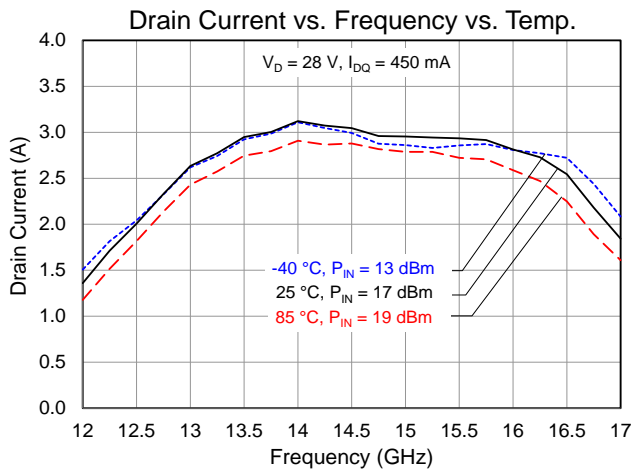
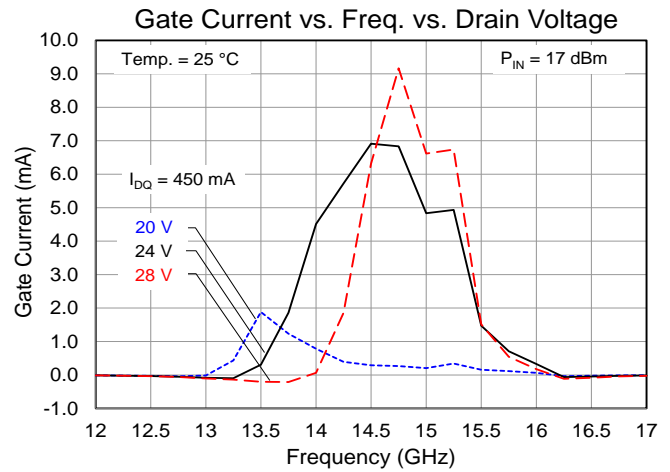
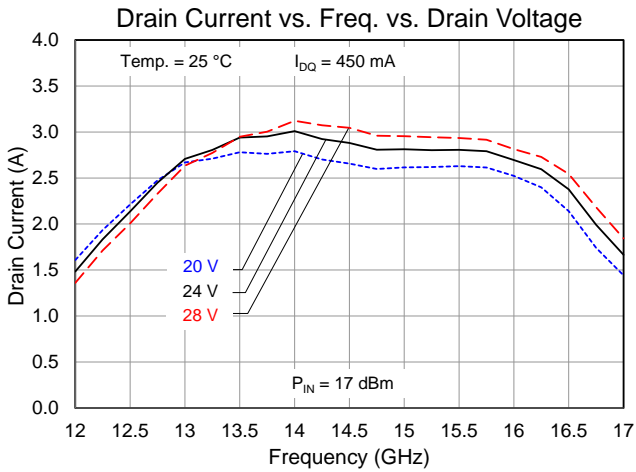
Typical Performance (CW Operation)



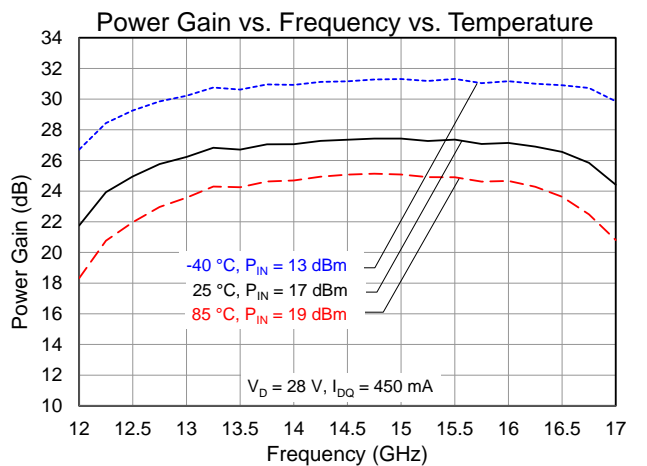
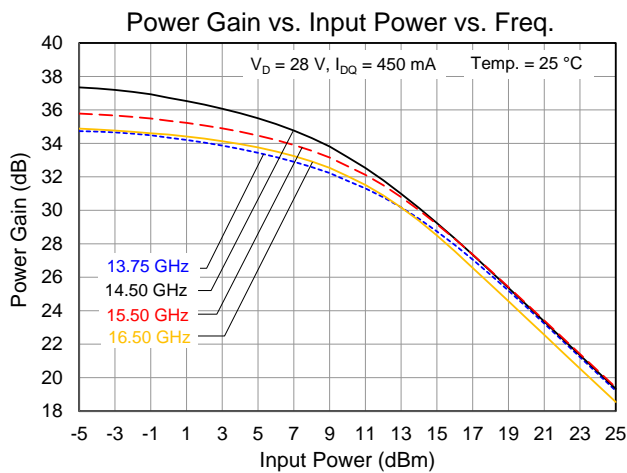
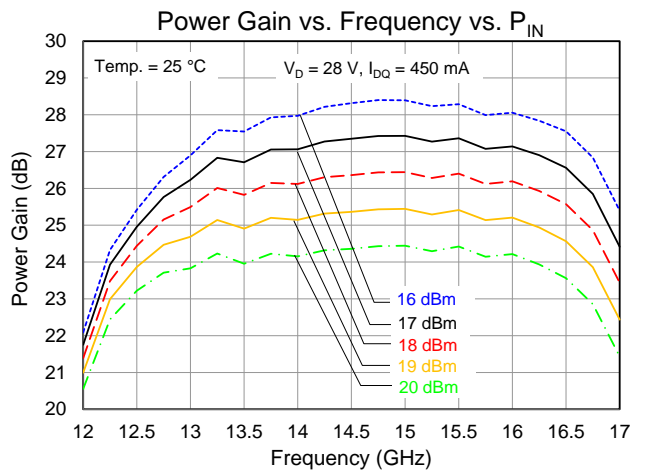
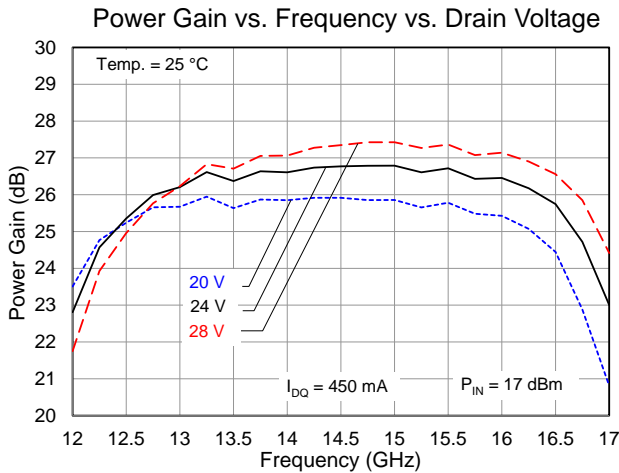
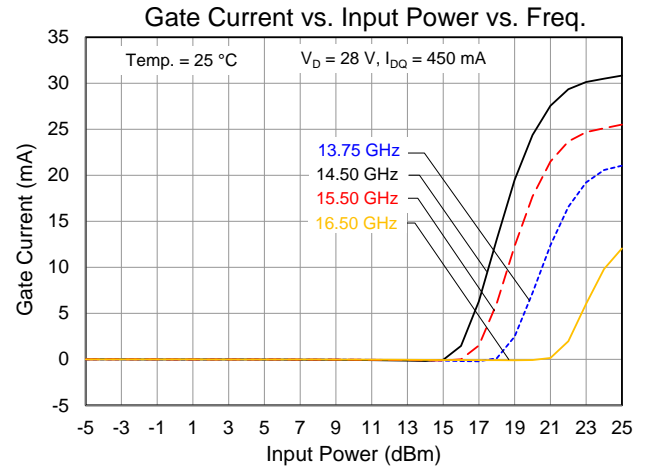
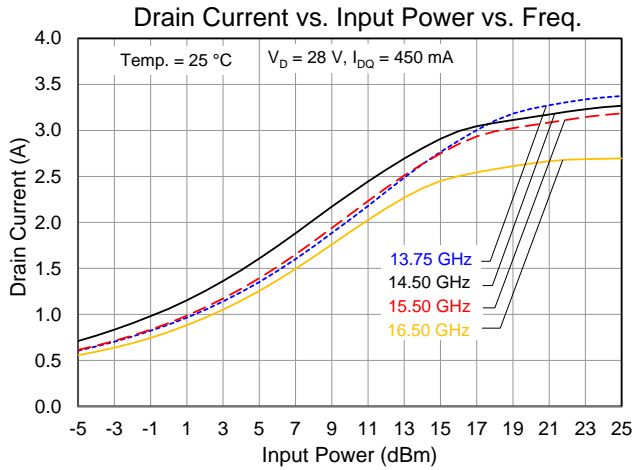
Typical Performance (CW Operation)



Typical Performance (CW Operation)

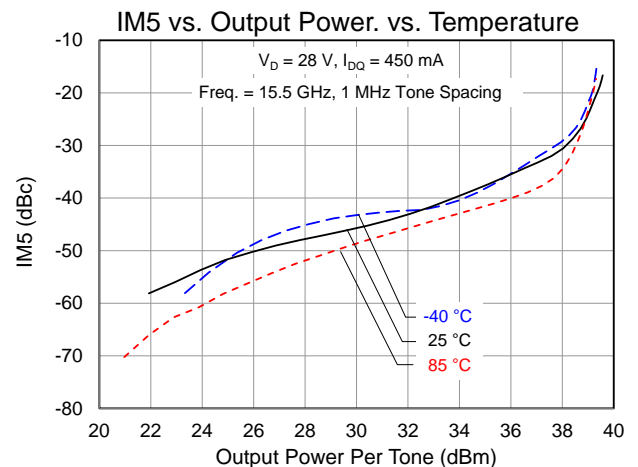
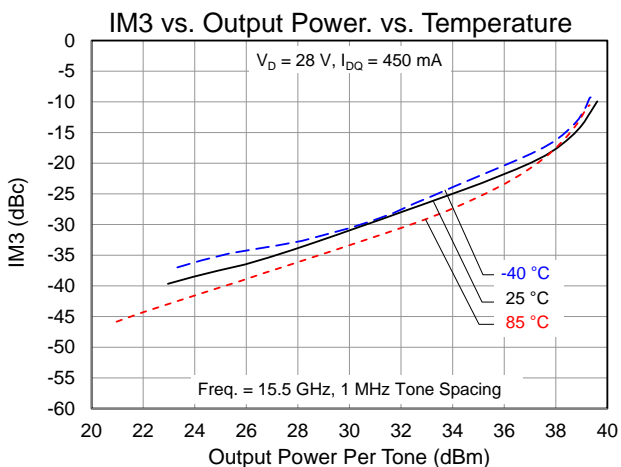
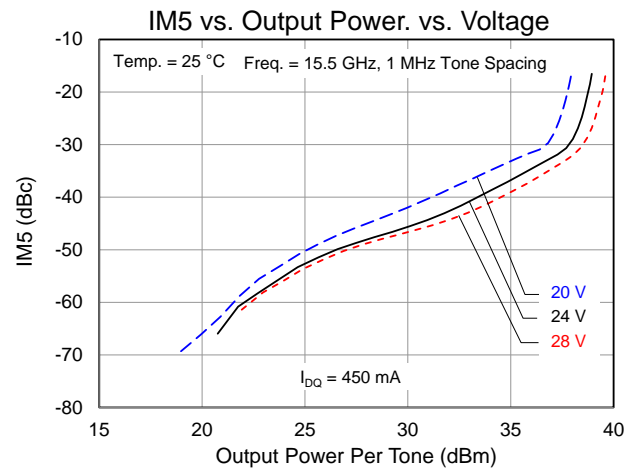
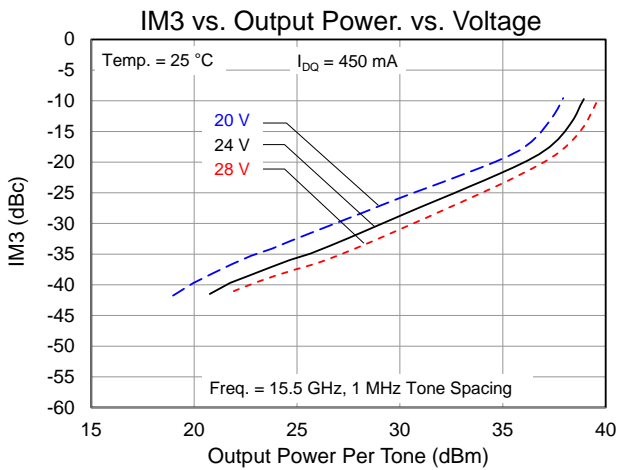
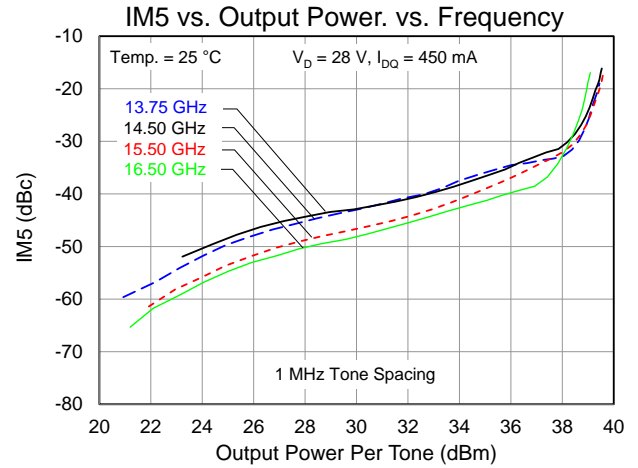
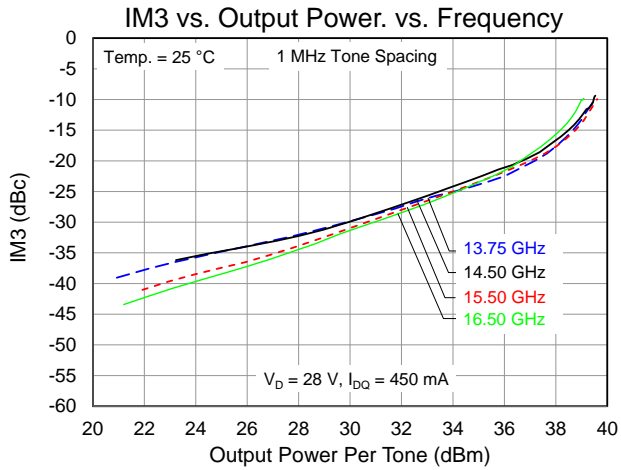


Typical Performance (CW Operation)

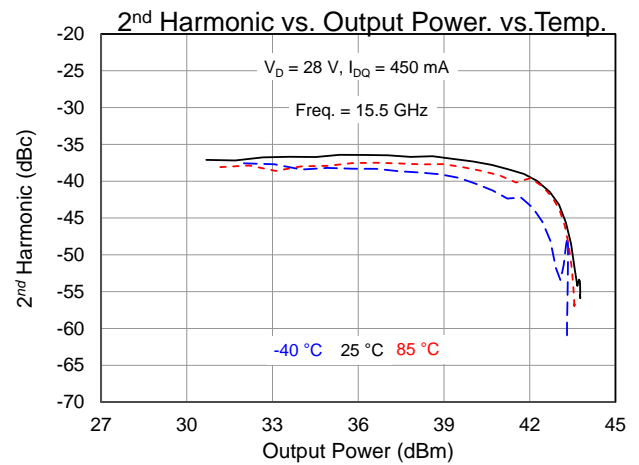
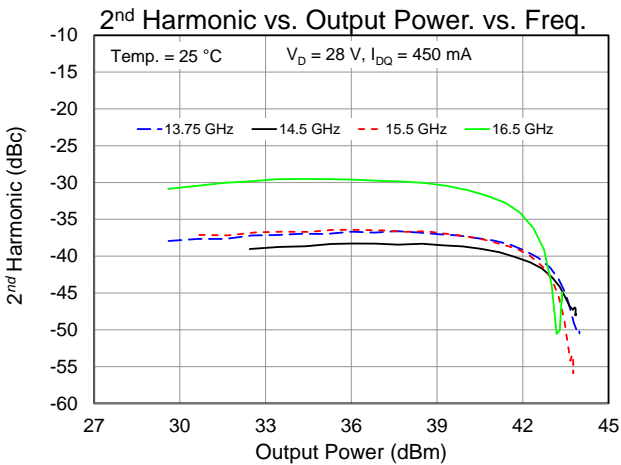
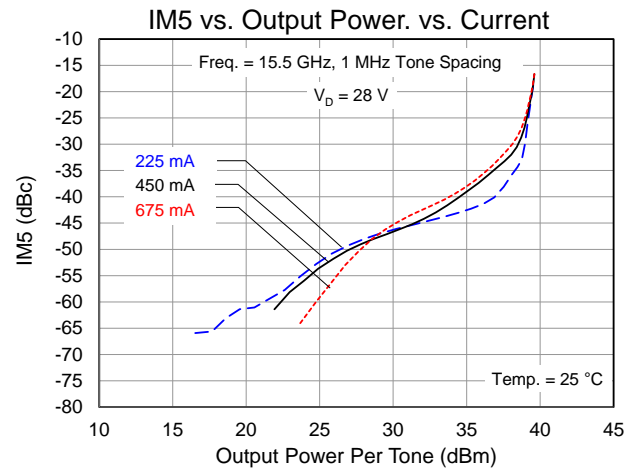
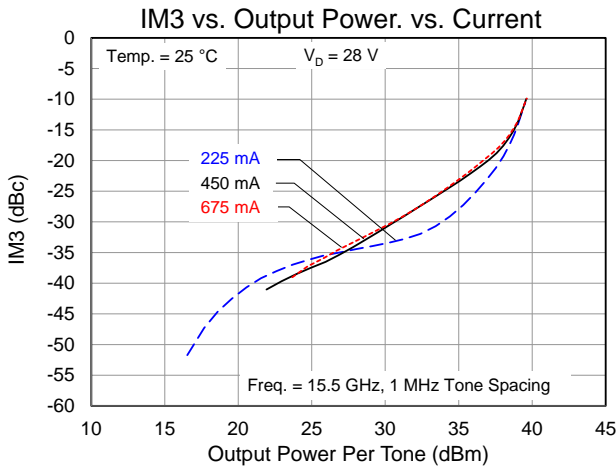




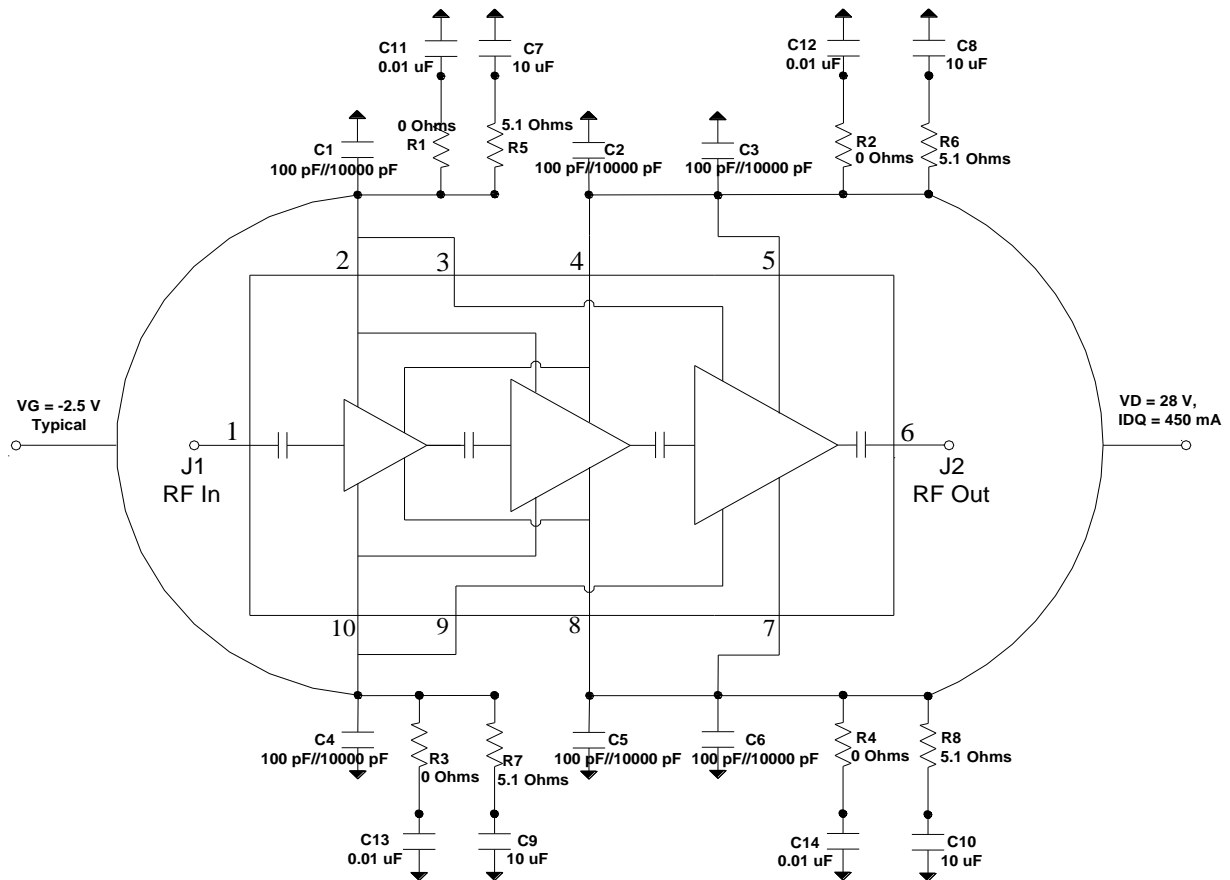
Typical Performance (Linearity)



**Typical Performance (Linearity)**



## Application Circuit



### Notes:

$V_G$  &  $V_D$  can be biased from either side of top or bottom.

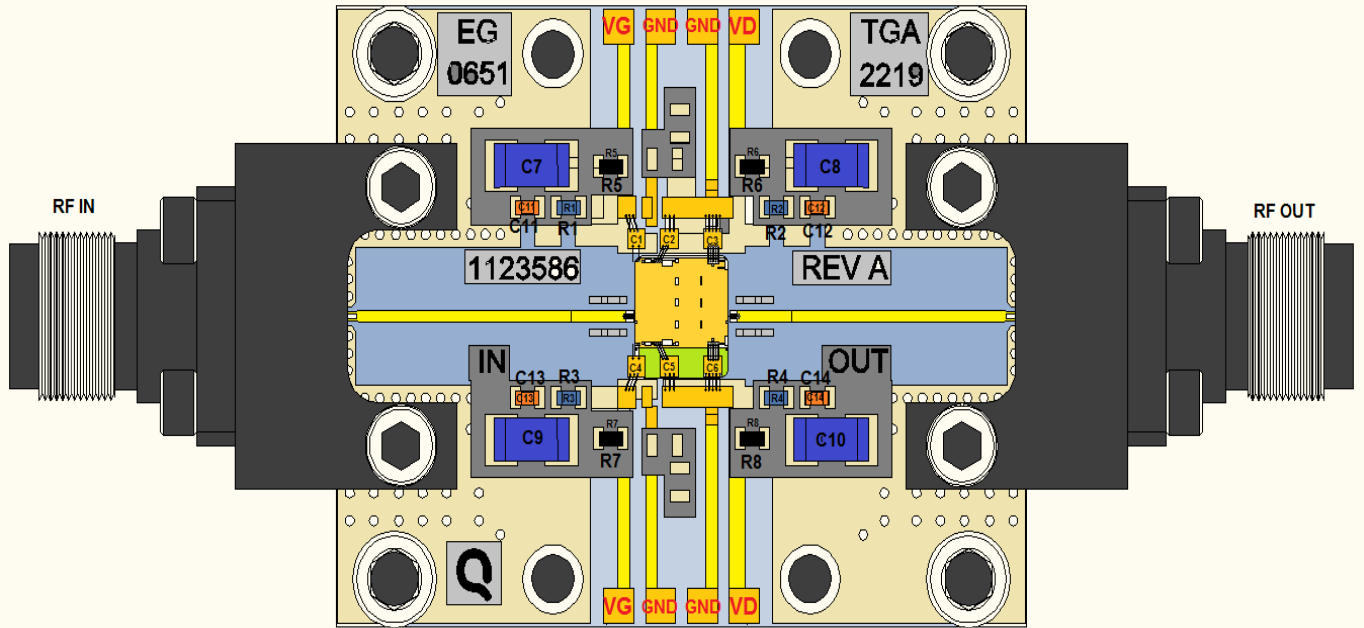
### Bias-up Procedure

1. Set  $I_D$  limit to 3.5 A,  $I_G$  limit to 50 mA
2. Set  $V_G$  to -5.0 V
3. Set  $V_D$  +28 V
4. Adjust  $V_G$  more positive until  $I_{DQ} = 450$  mA ( $V_G \sim -2.5$  V Typical)
5. Apply RF signal

### Bias-down Procedure

1. Turn off RF signal
2. Reduce  $V_G$  to -5.0 V. Ensure  $I_{DQ} \sim 0$  mA
3. Set  $V_D$  to 0 V
4. Turn off  $V_D$  supply
5. Turn off  $V_G$  supply

**Evaluation Board (EVB) Layout Assembly**

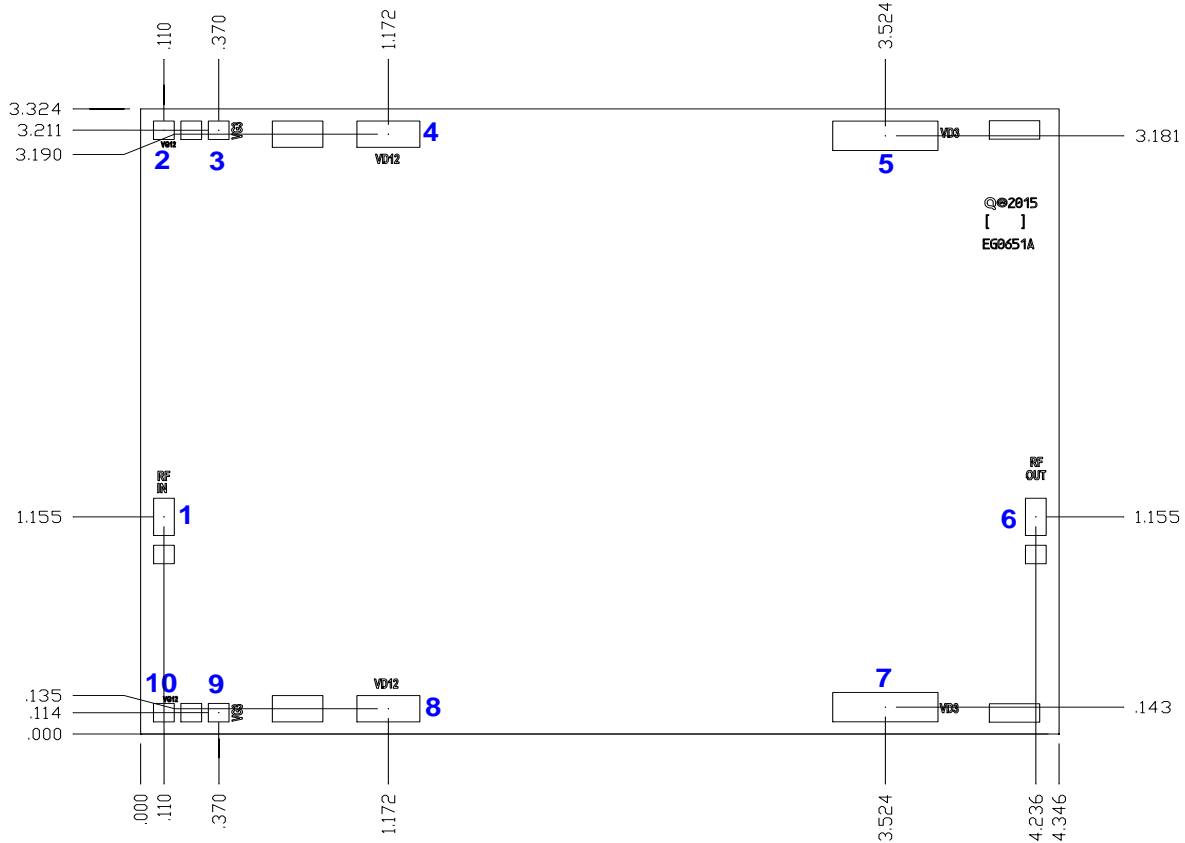


Notes:  $V_G$  &  $V_D$  can be biased from either side of top or bottom.

**Bill of Materials**

Reference Design	Value	Description	Manufacturer	Part Number
C1 – C6	100 pF    10000 pF	SLC, 50V	Various	
C7 – C10	10 uF	Cap, 1206, 50V, 20%, X5R	Various	
C11 – C14	0.01uF	Cap, 0402, 50V, 10%, X7R	Various	
R1 – R4	0 $\Omega$	Res, 0402, 5%, SMD	Various	
R5 – R8	5.1 $\Omega$	Res, 0402, 5%, 50 V, SMT	Various	

Mechanical Drawing & Bond Pad Description



Unit: millimeters  
 Thickness: 0.10  
 Die x, y size tolerance: +/- 0.050  
 Chip edge to bond pad dimensions are shown to center of pad  
 Ground is backside of die

Bond Pad	Symbol	Pad Size	Description
1	RF In	0.098 x 0.198	RF Input; matched to 50Ω; DC Blocked
2, 10	V <sub>G12</sub>	0.098 x 0.098	Gate voltage 1-2, bias network is required; see Application Circuit on page 11 as an example.
3, 9	V <sub>G3</sub>	0.098 x 0.098	Gate voltage 3, bias network is required; see Application Circuit on page 11 as an example.
4, 8	V <sub>D12</sub>	0.298 x 0.140	Drain voltage 1-2, bias network is required; see Application Circuit on page 11 as an example.
5, 7	V <sub>D3</sub>	0.498 x 0.156	Drain voltage 3, bias network is required; see Application Circuit on page 11 as an example.
6	RF Out	0.098 x 0.198	RF Output; matched to 50Ω; DC Blocked .

## Assembly Notes

Component placement and adhesive attachment assembly notes:

- Vacuum pencils and/or vacuum collets are the preferred method of pick up.
- Air bridges must be avoided during placement.
- The force impact is critical during auto placement.
- Organic attachment (i.e. epoxy) can be used in low-power applications.
- Curing should be done in a convection oven; proper exhaust is a safety concern.

Reflow process assembly notes:

- Use AuSn (80/20) solder and limit exposure to temperatures above 300°C to 3-4 minutes, maximum.
- An alloy station or conveyor furnace with reducing atmosphere should be used.
- Do not use any kind of flux.
- Coefficient of thermal expansion matching is critical for long-term reliability.
- Devices must be stored in a dry nitrogen atmosphere.

Interconnect process assembly notes:

- Thermosonic ball bonding is the preferred interconnect technique.
- Force, time, and ultrasonic are critical parameters.
- Aluminum wire should not be used.
- Devices with small pad sizes should be bonded with 0.0007-inch wire.

## Product Compliance Information

### ESD Sensitivity Ratings



Caution! ESD-Sensitive Device

ESD Rating: TBD  
Value: TBD  
Test: Human Body Model (HBM)  
Standard: JEDEC Standard JESD22-A114

### ECCN

US Department of Commerce: 3A001.b.2.c

### Solderability

Use only AuSn (80/20) solder and limit exposure to temperature above 300 °C to 3–4 minutes, maximum.

### RoHS–Compliance

This part is compliant with EU 2002/95/EC RoHS directive (Restrictions on the Use of Certain Hazardous Substances in Electrical and Electronic Equipment).

This product also has the following attributes:

- Lead Free
- Halogen Free (Chlorine, Bromine)
- Antimony Free
- TBBP-A (C<sub>15</sub>H<sub>12</sub>Br<sub>4</sub>O<sub>2</sub>) Free
- PFOS Free
- SVHC Free

## Contact Information

For the latest specifications, additional product information, worldwide sales and distribution locations, and information about TriQuint:

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Email: [info-sales@triquint.com](mailto:info-sales@triquint.com)

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Компания «ЭлектроПласт» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Оперативные поставки широкого спектра электронных компонентов отечественного и импортного производства напрямую от производителей и с крупнейших мировых складов;
- Поставка более 17-ти миллионов наименований электронных компонентов;
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- Лицензия ФСБ на осуществление работ с использованием сведений, составляющих государственную тайну;
- Поставка специализированных компонентов (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Aeroflex, Peregrine, Syfer, Eurofarad, Texas Instrument, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Помимо этого, одним из направлений компании «ЭлектроПласт» является направление «Источники питания». Мы предлагаем Вам помощь Конструкторского отдела:

- Подбор оптимального решения, техническое обоснование при выборе компонента;
- Подбор аналогов;
- Консультации по применению компонента;
- Поставка образцов и прототипов;
- Техническая поддержка проекта;
- Защита от снятия компонента с производства.



#### Как с нами связаться

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**Факс:** 8 (812) 320-02-42

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**Адрес:** 198099, г. Санкт-Петербург, ул. Калинина, дом 2, корпус 4, литера А.